

BFP840ESD

Robust Low Noise Silicon Germanium Bipolar RF Transistor

Data Sheet

Revision 1.2, 2013-03-28

Edition 2013-03-28

**Published by
Infineon Technologies AG
81726 Munich, Germany**

**© 2013 Infineon Technologies AG
All Rights Reserved.**

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

Infineon Technologies components may be used in life-support devices or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

BFP840ESD, Robust Low Noise Silicon Germanium Bipolar RF Transistor

Revision History: 2013-03-28, Revision 1.2

Page	Subjects (major changes since last revision)
	This data sheet replaces the revision from 2012-07-11.
P. 8	Item about AEC-Q101 added to feature list, minor changes.
P. 27	Picture for marking description updated.

Trademarks of Infineon Technologies AG

AURIX™, C166™, CanPAK™, CIPOS™, CIPURSE™, EconoPACK™, CoolMOS™, CoolSET™, CORECONTROL™, CROSSAVE™, DAVE™, DI-POL™, EasyPIM™, EconoBRIDGE™, EconoDUAL™, EconoPIM™, EconoPACK™, EiceDRIVER™, eupec™, FCOS™, HITFET™, HybridPACK™, I²RF™, ISOFACE™, IsoPACK™, MIPAQ™, ModSTACK™, my-d™, NovalithIC™, OptiMOS™, ORIGA™, POWERCODE™, PRIMARION™, PrimePACK™, PrimeSTACK™, PRO-SIL™, PROFET™, RASIC™, ReverSave™, SatRIC™, SIEGET™, SINDRION™, SIPMOS™, SmartLEWIS™, SOLID FLASH™, TEMPFET™, thinQ!™, TRENCHSTOP™, TriCore™.

Other Trademarks

Advance Design System™ (ADS) of Agilent Technologies, AMBA™, ARM™, MULTI-ICE™, KEIL™, PRIMECELL™, REALVIEW™, THUMB™, µVision™ of ARM Limited, UK. AUTOSAR™ is licensed by AUTOSAR development partnership. Bluetooth™ of Bluetooth SIG Inc. CAT-ig™ of DECT Forum. COLOSSUS™, FirstGPS™ of Trimble Navigation Ltd. EMV™ of EMVCo, LLC (Visa Holdings Inc.). EPCOS™ of Epcos AG. FLEXGO™ of Microsoft Corporation. FlexRay™ is licensed by FlexRay Consortium. HYPERTERMINAL™ of Hilgraeve Incorporated. IEC™ of Commission Electrotechnique Internationale. IrDA™ of Infrared Data Association Corporation. ISO™ of INTERNATIONAL ORGANIZATION FOR STANDARDIZATION. MATLAB™ of MathWorks, Inc. MAXIM™ of Maxim Integrated Products, Inc. MICROTEC™, NUCLEUS™ of Mentor Graphics Corporation. MIPI™ of MIPI Alliance, Inc. MIPS™ of MIPS Technologies, Inc., USA. muRata™ of MURATA MANUFACTURING CO., MICROWAVE OFFICE™ (MWO) of Applied Wave Research Inc., OmniVision™ of OmniVision Technologies, Inc. Openwave™ Openwave Systems Inc. RED HAT™ Red Hat, Inc. RFMD™ RF Micro Devices, Inc. SIRIUS™ of Sirius Satellite Radio Inc. SOLARIS™ of Sun Microsystems, Inc. SPANSION™ of Spansion LLC Ltd. Symbian™ of Symbian Software Limited. TAIYO YUDEN™ of Taiyo Yuden Co. TEAKLITE™ of CEVA, Inc. TEKTRONIX™ of Tektronix Inc. TOKO™ of TOKO KABUSHIKI KAISHA TA. UNIX™ of X/Open Company Limited. VERILOG™, PALLADIUM™ of Cadence Design Systems, Inc. VLYNQ™ of Texas Instruments Incorporated. VXWORKS™, WIND RIVER™ of WIND RIVER SYSTEMS, INC. ZETEX™ of Diodes Zetex Limited.

Last Trademarks Update 2011-11-11

Table of Contents

	Table of Contents	4
	List of Figures	5
	List of Tables	6
1	Product Brief	7
2	Features	8
3	Maximum Ratings	9
4	Thermal Characteristics	10
5	Electrical Characteristics	11
5.1	DC Characteristics	11
5.2	General AC Characteristics	11
5.3	Frequency Dependent AC Characteristics	12
5.4	Characteristic DC Diagrams	16
5.5	Characteristic AC Diagrams	19
6	Simulation Data	26
7	Package Information SOT343	27

List of Figures

Figure 4-1	Total Power Dissipation $P_{tot} = f(T_s)$	10
Figure 5-1	BFP840ESD Testing Circuit	12
Figure 5-2	Collector Current vs. Collector Emitter Voltage $I_C = f(V_{CE}), I_B = \text{Parameter}$	16
Figure 5-3	DC Current Gain $h_{FE} = f(I_C), V_{CE} = 1.8 \text{ V}$	16
Figure 5-4	Collector Current vs. Base Emitter Forward Voltage $I_C = f(V_{BE}), V_{CE} = 1.8 \text{ V}$	17
Figure 5-5	Base Current vs. Base Emitter Forward Voltage $I_B = f(V_{BE}), V_{CE} = 1.8 \text{ V}$	17
Figure 5-6	Base Current vs. Base Emitter Reverse Voltage $I_B = f(V_{EB}), V_{CE} = 1.8 \text{ V}$	18
Figure 5-7	Transition Frequency $f_T = f(I_C), f = 2 \text{ GHz}, V_{CE} = \text{Parameter}$	19
Figure 5-8	3rd Order Intercept Point at output $OIP3 = f(I_C), Z_S = Z_L = 50 \Omega, V_{CE}, f = \text{Parameters}$	19
Figure 5-9	3rd Order Intercept Point at output $OIP3 \text{ [dBm]} = f(I_C, V_{CE}), Z_S = Z_L = 50 \Omega, f = 5.5 \text{ GHz}$	20
Figure 5-10	Compression Point at output $OP_{1dB} \text{ [dBm]} = f(I_C, V_{CE}), Z_S = Z_L = 50 \Omega, f = 5.5 \text{ GHz}$	20
Figure 5-11	Collector Base Capacitance $C_{CB} = f(V_{CB}), f = 1 \text{ MHz}$	21
Figure 5-12	Gain $G_{ma}, G_{ms}, S_{21} ^2 = f(f), V_{CE} = 1.8 \text{ V}, I_C = 10 \text{ mA}$	21
Figure 5-13	Maximum Power Gain $G_{max} = f(I_C), V_{CE} = 1.8 \text{ V}, f = \text{Parameter in GHz}$	22
Figure 5-14	Maximum Power Gain $G_{max} = f(V_{CE}), I_C = 10 \text{ mA}, f = \text{Parameter in GHz}$	22
Figure 5-15	Input Reflection Coefficient $S_{11} = f(f), V_{CE} = 1.8 \text{ V}, I_C = 5 / 10 / 15 \text{ mA}$	23
Figure 5-16	Source Impedance for Minimum Noise Figure $Z_{opt} = f(f), V_{CE} = 1.8 \text{ V}, I_C = 5 / 10 / 15 \text{ mA}$	23
Figure 5-17	Output Reflection Coefficient $S_{22} = f(f), V_{CE} = 1.8 \text{ V}, I_C = 5 / 10 / 15 \text{ mA}$	24
Figure 5-18	Noise Figure $NF_{min} = f(f), V_{CE} = 1.8 \text{ V}, I_C = 5 / 10 / 15 \text{ mA}, Z_S = Z_{opt}$	24
Figure 5-19	Noise Figure $NF_{min} = f(I_C), V_{CE} = 1.8 \text{ V}, Z_S = Z_{opt}, f = \text{Parameter in GHz}$	25
Figure 5-20	Noise Figure $NF_{50} = f(I_C), V_{CE} = 1.8 \text{ V}, Z_S = 50 \Omega, f = \text{Parameter in GHz}$	25
Figure 7-1	Package Outline	27
Figure 7-2	Package Footprint	27
Figure 7-3	Marking Description (Marking BFP840ESD: T8s)	27
Figure 7-4	Tape Dimensions	27

List of Tables

Table 3-1	Maximum Ratings at $T_A = 25\text{ °C}$ (unless otherwise specified)	9
Table 4-1	Thermal Resistance	10
Table 5-1	DC Characteristics at $T_A = 25\text{ °C}$	11
Table 5-2	General AC Characteristics at $T_A = 25\text{ °C}$	11
Table 5-3	AC Characteristics, $V_{CE} = 1.8\text{ V}, f = 0.45\text{ GHz}$	12
Table 5-4	AC Characteristics, $V_{CE} = 1.8\text{ V}, f = 0.9\text{ GHz}$	13
Table 5-5	AC Characteristics, $V_{CE} = 1.8\text{ V}, f = 1.5\text{ GHz}$	13
Table 5-6	AC Characteristics, $V_{CE} = 1.8\text{ V}, f = 1.9\text{ GHz}$	13
Table 5-7	AC Characteristics, $V_{CE} = 1.8\text{ V}, f = 2.4\text{ GHz}$	14
Table 5-8	AC Characteristics, $V_{CE} = 1.8\text{ V}, f = 3.5\text{ GHz}$	14
Table 5-9	AC Characteristics, $V_{CE} = 1.8\text{ V}, f = 5.5\text{ GHz}$	14
Table 5-10	AC Characteristics, $V_{CE} = 1.8\text{ V}, f = 10\text{ GHz}$	15
Table 5-11	AC Characteristics, $V_{CE} = 1.8\text{ V}, f = 12\text{ GHz}$	15

1 Product Brief

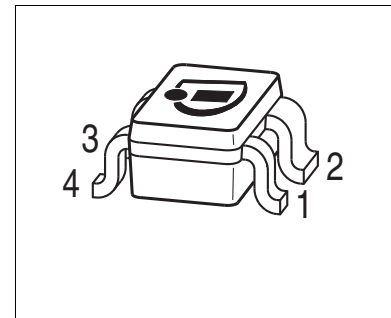
The BFP840ESD is a high performance HBT (Heterojunction Bipolar Transistor) specifically designed for 5-6 GHz Wi-Fi applications. The device is based on Infineon's reliable high volume SiGe:C technology.

The BFP840ESD provides inherently good input and output power match as well as inherently good noise match at 5-6 GHz. The simultaneous noise and power match without lossy external matching components at the input leads to a low external parts count, to a very good noise figure and to a very high transducer gain in the Wi-Fi application. Integrated protection elements at in- and output make the device robust against ESD and excessive RF input power.

The device offers its high performance at low current and voltage and is especially well-suited for portable battery-powered applications in which energy efficiency is a key requirement. The device comes in an easy to use industry standard package with visible leads.

2 Features

- Robust very low noise amplifier based on Infineon’s reliable high volume SiGe:C technology
- Unique combination of high end RF performance and robustness: 20 dBm maximum RF input power, 1.5 kV HBM ESD hardness
- Very high transition frequency $f_T = 80$ GHz enables very low noise figure at high frequencies:
 $NF_{min} = 0.85$ dB at 5.5 GHz, 1.8 V, 6 mA
- High gain $|S_{21}|^2 = 18.5$ dB at 5.5 GHz, 1.8 V, 10 mA
- $OIP3 = 23$ dBm at 5.5 GHz, 1.5 V, 6 mA
- Ideal for low voltage applications e.g. $V_{CC} = 1.2$ V and 1.8 V (2.85 V, 3.3 V, 3.6 V requires corresponding collector resistor)
- Low power consumption, ideal for mobile applications
- Easy to use Pb free (RoHS compliant) and halogen free industry standard package with visible leads
- Qualification report according to AEC-Q101 available



SOT343



Applications

As Low Noise Amplifier (LNA) in

- Mobile and fixed connectivity applications: WLAN 802.11, WiMAX and UWB
- Satellite communication systems: satellite radio (SDARs, DAB), navigation systems (e.g. GPS, Glonass) and C-band LNB (1st and 2nd stage LNA)
- Ku-band LNB front-end (2nd stage or 3rd stage LNA and active mixer)
- Ka-band oscillators (DROs)

Attention: ESD (Electrostatic discharge) sensitive device, observe handling precautions

Product Name	Package	Pin Configuration				Marking
BFP840ESD	SOT343	1 = B	2 = E	3 = C	4 = E	T8s

3 Maximum Ratings

Table 3-1 Maximum Ratings at $T_A = 25\text{ °C}$ (unless otherwise specified)

Parameter	Symbol	Values		Unit	Note / Test Condition
		Min.	Max.		
Collector emitter voltage	V_{CEO}	–	2.25 2.0	V	$T_A = 25\text{ °C}$ $T_A = -55\text{ °C}$ Open base
Collector emitter voltage ¹⁾	V_{CES}	–	2.25 2.0	V	$T_A = 25\text{ °C}$ $T_A = -55\text{ °C}$ E-B short circuited
Collector base voltage ²⁾	V_{CBO}	–	2.9 2.6	V	$T_A = 25\text{ °C}$ $T_A = -55\text{ °C}$ Open emitter
Base current	I_B	-5	3	mA	–
Collector current	I_C	–	35	mA	–
RF input power	P_{RFIn}	–	20	dBm	–
ESD stress pulse	V_{ESD}	-1.5	1.5	kV	HBM, all pins, acc. to JESD22-A114
Total power dissipation ³⁾	P_{tot}	–	75	mW	$T_S \leq 108\text{ °C}$
Junction temperature	T_J	–	150	°C	–
Storage temperature	T_{Stg}	-55	150	°C	–

1) V_{CES} is identical to V_{CEO} due to design.

2) V_{CBO} is similar to V_{CEO} due to design.

3) T_S is the soldering point temperature. T_S is measured on the emitter lead at the soldering point of the pcb.

Attention: Stresses above the max. values listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the integrated circuit.

4 Thermal Characteristics

Table 4-1 Thermal Resistance

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Junction - soldering point ¹⁾	R_{thJS}	–	551	–	K/W	–

1) For the definition of R_{thJS} please refer to Application Note AN077 (Thermal Resistance Calculation).

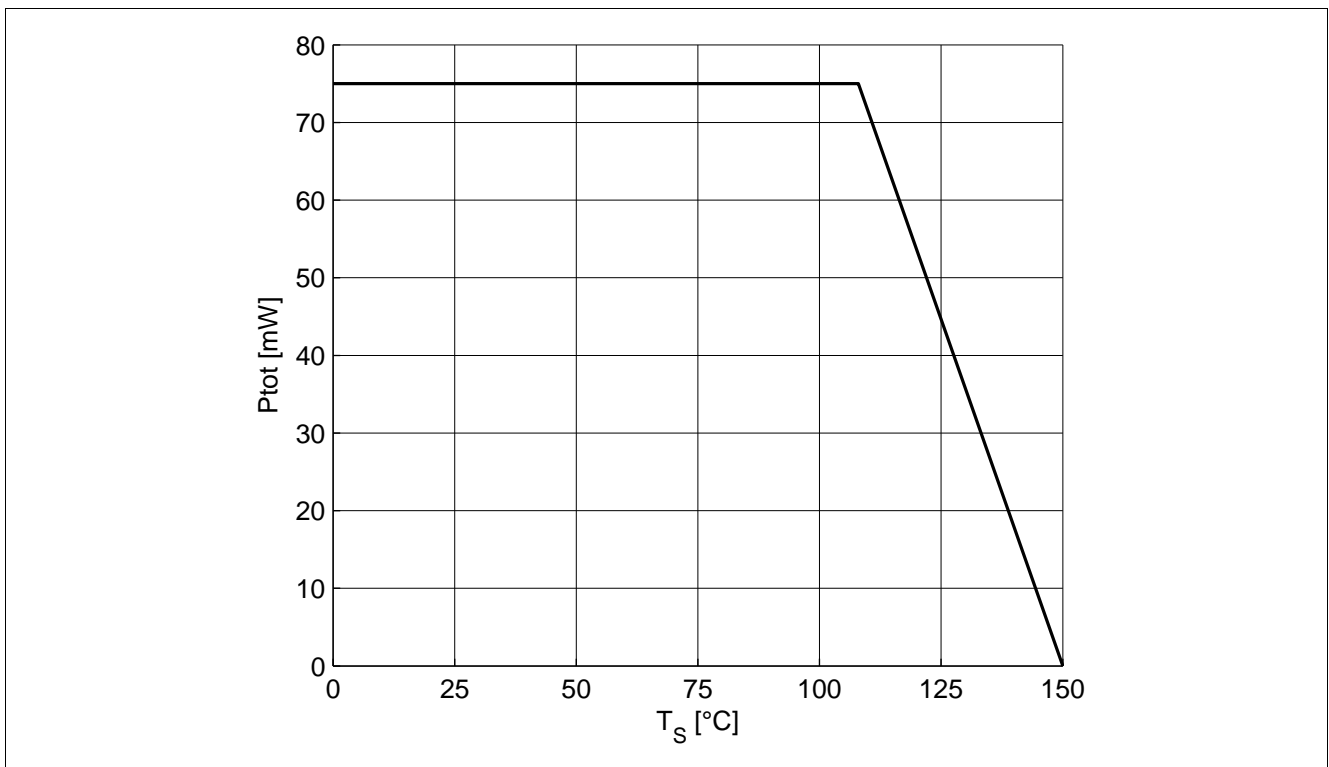


Figure 4-1 Total Power Dissipation $P_{tot} = f(T_s)$

5 Electrical Characteristics

5.1 DC Characteristics

Table 5-1 DC Characteristics at $T_A = 25\text{ }^\circ\text{C}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Collector emitter breakdown voltage	$V_{(BR)CEO}$	2.25	2.6		V	$I_C = 1\text{ mA}$, $I_B = 0$ Open base
Collector emitter leakage current	I_{CES}	–	–	400	nA	$V_{CE} = 1.5\text{ V}$, $V_{BE} = 0$ E-B short circuited
Collector base leakage current	I_{CBO}	–	–	400	nA	$V_{CB} = 1.5\text{ V}$, $I_E = 0$ Open emitter
Emitter base leakage current	I_{EBO}	–	–	10	μA	$V_{EB} = 0.5\text{ V}$, $I_C = 0$ Open collector
DC current gain	h_{FE}	150	260	450		$V_{CE} = 1.8\text{ V}$, $I_C = 10\text{ mA}$ Pulse measured

5.2 General AC Characteristics

Table 5-2 General AC Characteristics at $T_A = 25\text{ }^\circ\text{C}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Transition frequency	f_T	–	80	–	GHz	$V_{CE} = 1.8\text{ V}$, $I_C = 25\text{ mA}$ $f = 2\text{ GHz}$
Collector base capacitance	C_{CB}	–	37	–	fF	$V_{CB} = 1.8\text{ V}$, $V_{BE} = 0$ $f = 1\text{ MHz}$ Emitter grounded
Collector emitter capacitance	C_{CE}	–	0.40	–	pF	$V_{CE} = 1.8\text{ V}$, $V_{BE} = 0$ $f = 1\text{ MHz}$ Base grounded
Emitter base capacitance	C_{EB}	–	0.41	–	pF	$V_{EB} = 0.4\text{ V}$, $V_{CB} = 0$ $f = 1\text{ MHz}$ Collector grounded

5.3 Frequency Dependent AC Characteristics

Measurement setup is a test fixture with Bias T's in a 50 Ω system, $T_A = 25\text{ }^\circ\text{C}$

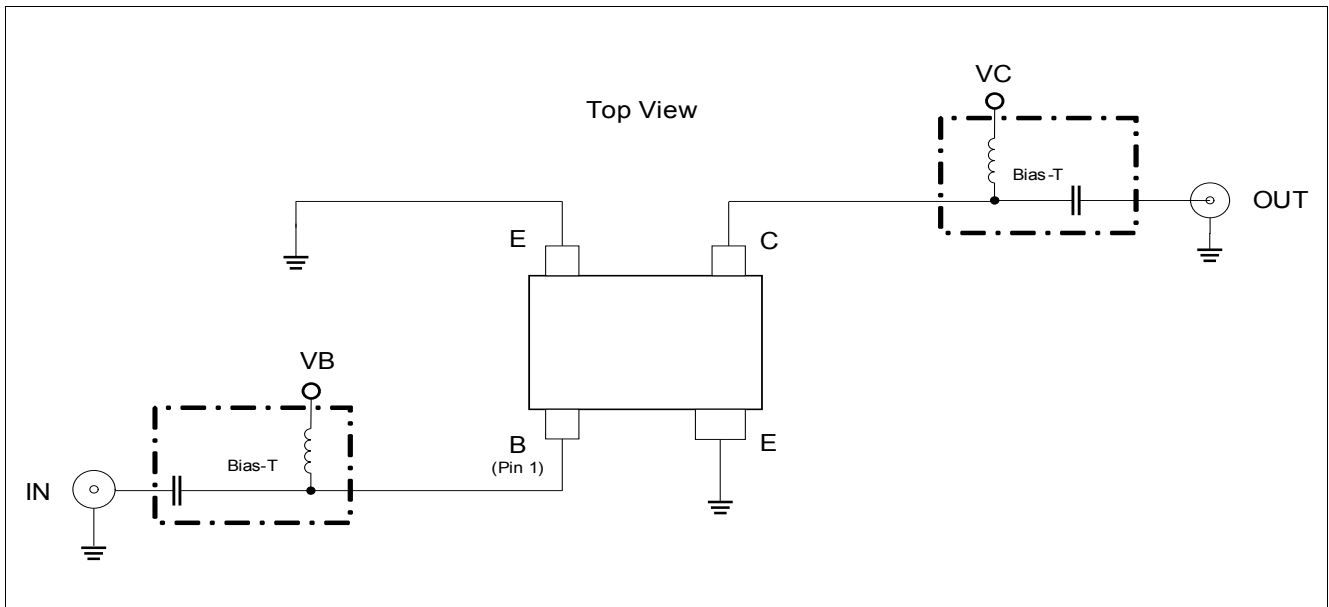


Figure 5-1 BFP840ESD Testing Circuit

Table 5-3 AC Characteristics, $V_{CE} = 1.8\text{ V}$, $f = 0.45\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain					dB	
Maximum power gain	G_{rms}	–	33.5	–		$I_C = 10\text{ mA}$
Transducer gain	$ S_{21} ^2$	–	27.5	–		$I_C = 10\text{ mA}$
Minimum Noise Figure					dB	
Minimum noise figure	NF_{min}	–	0.6	–		$I_C = 5\text{ mA}$
Associated gain	G_{ass}	–	26.5	–		$I_C = 5\text{ mA}$
Linearity					dBm	$Z_S = Z_L = 50\ \Omega$
1 dB compression point at output	OP_{1dB}	–	4	–		$I_C = 10\text{ mA}$
3rd order intercept point at output	$OIP3$	–	19.5	–		$I_C = 10\text{ mA}$

Electrical Characteristics
Table 5-4 AC Characteristics, $V_{CE} = 1.8\text{ V}$, $f = 0.9\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain						
Maximum power gain	G_{ms}	–	30	–	dB	$I_C = 10\text{ mA}$
Transducer gain	$ S_{21} ^2$	–	27	–		$I_C = 10\text{ mA}$
Minimum Noise Figure						
Minimum noise figure	NF_{min}	–	0.6	–	dB	$I_C = 5\text{ mA}$
Associated gain	G_{ass}	–	25.5	–		$I_C = 5\text{ mA}$
Linearity						
1 dB compression point at output	OP_{1dB}	–	4	–	dBm	$Z_S = Z_L = 50\ \Omega$ $I_C = 10\text{ mA}$
3rd order intercept point at output	$OIP3$	–	19.5	–		$I_C = 10\text{ mA}$

Table 5-5 AC Characteristics, $V_{CE} = 1.8\text{ V}$, $f = 1.5\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain						
Maximum power gain	G_{ms}	–	28	–	dB	$I_C = 10\text{ mA}$
Transducer gain	$ S_{21} ^2$	–	25.5	–		$I_C = 10\text{ mA}$
Minimum Noise Figure						
Minimum noise figure	NF_{min}	–	0.65	–	dB	$I_C = 5\text{ mA}$
Associated gain	G_{ass}	–	24	–		$I_C = 5\text{ mA}$
Linearity						
1 dB compression point at output	OP_{1dB}	–	4.0	–	dBm	$Z_S = Z_L = 50\ \Omega$ $I_C = 10\text{ mA}$
3rd order intercept point at output	$OIP3$	–	19.5	–		$I_C = 10\text{ mA}$

Table 5-6 AC Characteristics, $V_{CE} = 1.8\text{ V}$, $f = 1.9\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain						
Maximum power gain	G_{ms}	–	27	–	dB	$I_C = 10\text{ mA}$
Transducer gain	$ S_{21} ^2$	–	25	–		$I_C = 10\text{ mA}$
Minimum Noise Figure						
Minimum noise figure	NF_{min}	–	0.65	–	dB	$I_C = 5\text{ mA}$
Associated gain	G_{ass}	–	23	–		$I_C = 5\text{ mA}$
Linearity						
1 dB compression point at output	OP_{1dB}	–	4.5	–	dBm	$Z_S = Z_L = 50\ \Omega$ $I_C = 10\text{ mA}$
3rd order intercept point at output	$OIP3$	–	21	–		$I_C = 10\text{ mA}$

Electrical Characteristics
Table 5-7 AC Characteristics, $V_{CE} = 1.8\text{ V}$, $f = 2.4\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain						
Maximum power gain	G_{ms}	–	26	–	dB	$I_C = 10\text{ mA}$
Transducer gain	$ S_{21} ^2$	–	24	–		$I_C = 10\text{ mA}$
Minimum Noise Figure						
Minimum noise figure	NF_{min}	–	0.7	–	dB	$I_C = 5\text{ mA}$
Associated gain	G_{ass}	–	22	–		$I_C = 5\text{ mA}$
Linearity						
1 dB compression point at output	OP_{1dB}	–	4	–	dBm	$Z_S = Z_L = 50\ \Omega$
3rd order intercept point at output	$OIP3$	–	21	–		$I_C = 10\text{ mA}$

Table 5-8 AC Characteristics, $V_{CE} = 1.8\text{ V}$, $f = 3.5\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain						
Maximum power gain	G_{ms}	–	24.5	–	dB	$I_C = 10\text{ mA}$
Transducer gain	$ S_{21} ^2$	–	22	–		$I_C = 10\text{ mA}$
Minimum Noise Figure						
Minimum noise figure	NF_{min}	–	0.7	–	dB	$I_C = 5\text{ mA}$
Associated gain	G_{ass}	–	20	–		$I_C = 5\text{ mA}$
Linearity						
1 dB compression point at output	OP_{1dB}	–	5	–	dBm	$Z_S = Z_L = 50\ \Omega$
3rd order intercept point at output	$OIP3$	–	22.5	–		$I_C = 10\text{ mA}$

Table 5-9 AC Characteristics, $V_{CE} = 1.8\text{ V}$, $f = 5.5\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain						
Maximum power gain	G_{ma}	–	22.5	–	dB	$I_C = 10\text{ mA}$
Transducer gain	$ S_{21} ^2$	–	18.5	–		$I_C = 10\text{ mA}$
Minimum Noise Figure						
Minimum noise figure	NF_{min}	–	0.85	–	dB	$I_C = 5\text{ mA}$
Associated gain	G_{ass}	–	17	–		$I_C = 5\text{ mA}$
Linearity						
1 dB compression point at output	OP_{1dB}	–	5	–	dBm	$Z_S = Z_L = 50\ \Omega$
3rd order intercept point at output	$OIP3$	–	22	–		$I_C = 10\text{ mA}$

Table 5-10 AC Characteristics, $V_{CE} = 1.8\text{ V}$, $f = 10\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain						
Maximum power gain	G_{ms}	–	17	–	dB	$I_C = 10\text{ mA}$
Transducer gain	$ S_{21} ^2$	–	12	–		$I_C = 10\text{ mA}$
Minimum Noise Figure						
Minimum noise figure	NF_{min}	–	1.2	–	dB	$I_C = 5\text{ mA}$
Associated gain	G_{ass}	–	12.5	–		$I_C = 5\text{ mA}$
Linearity						
1 dB compression point at output	OP_{1dB}	–	2.5	–	dBm	$Z_S = Z_L = 50\ \Omega$
3rd order intercept point at output	$OIP3$	–	19.5	–		$I_C = 10\text{ mA}$

Table 5-11 AC Characteristics, $V_{CE} = 1.8\text{ V}$, $f = 12\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power gain						
Maximum power gain	G_{ms}	–	15.5	–	dB	$I_C = 10\text{ mA}$
Transducer gain	$ S_{21} ^2$	–	9.5	–		$I_C = 10\text{ mA}$
Minimum Noise Figure						
Minimum noise figure	NF_{min}	–	1.45	–	dB	$I_C = 5\text{ mA}$
Associated gain	G_{ass}	–	11	–		$I_C = 5\text{ mA}$
Linearity						
1 dB compression point at output	OP_{1dB}	–	1.5	–	dBm	$Z_S = Z_L = 50\ \Omega$
3rd order intercept point at output	$OIP3$	–	18.5	–		$I_C = 10\text{ mA}$

Note: $OIP3$ value depends on termination of all intermodulation frequency components. Termination used for this measurement is $50\ \Omega$ from 0.2 MHz to 12 GHz .

5.4 Characteristic DC Diagrams

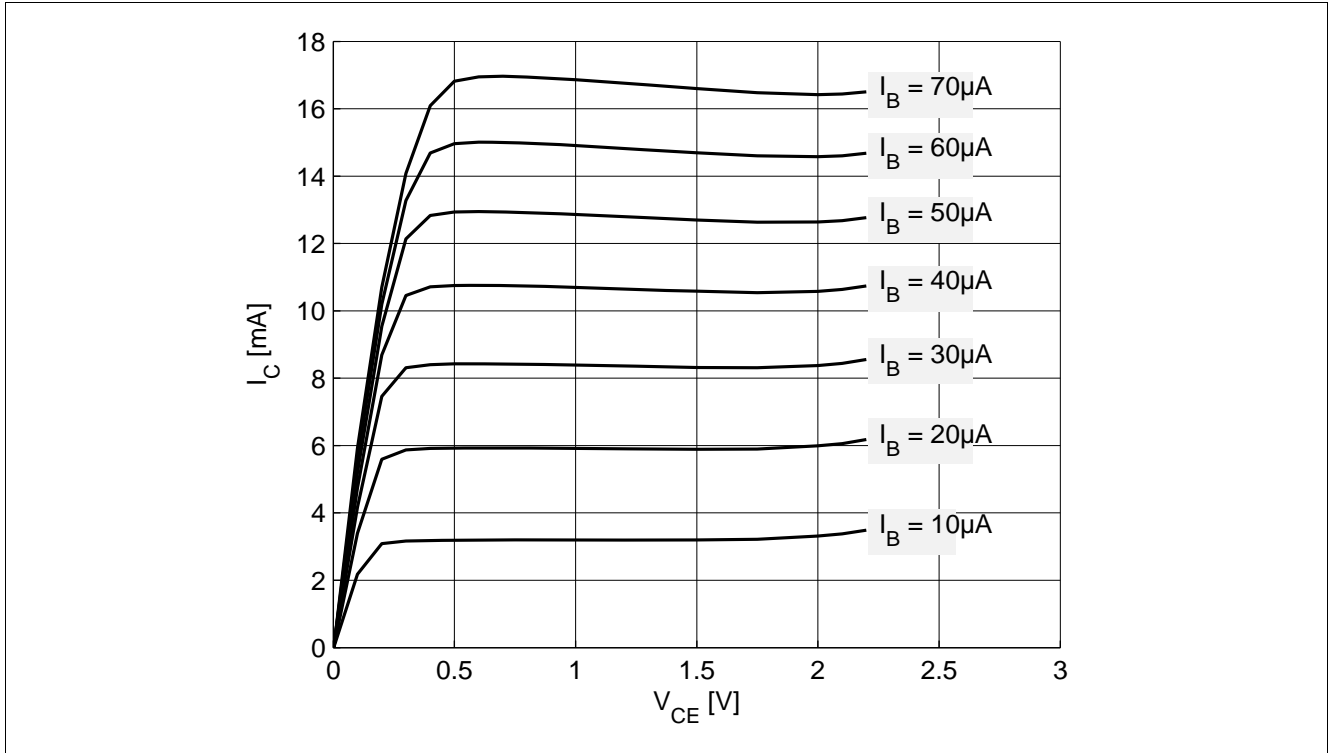


Figure 5-2 Collector Current vs. Collector Emitter Voltage $I_C = f(V_{CE}), I_B = \text{Parameter}$

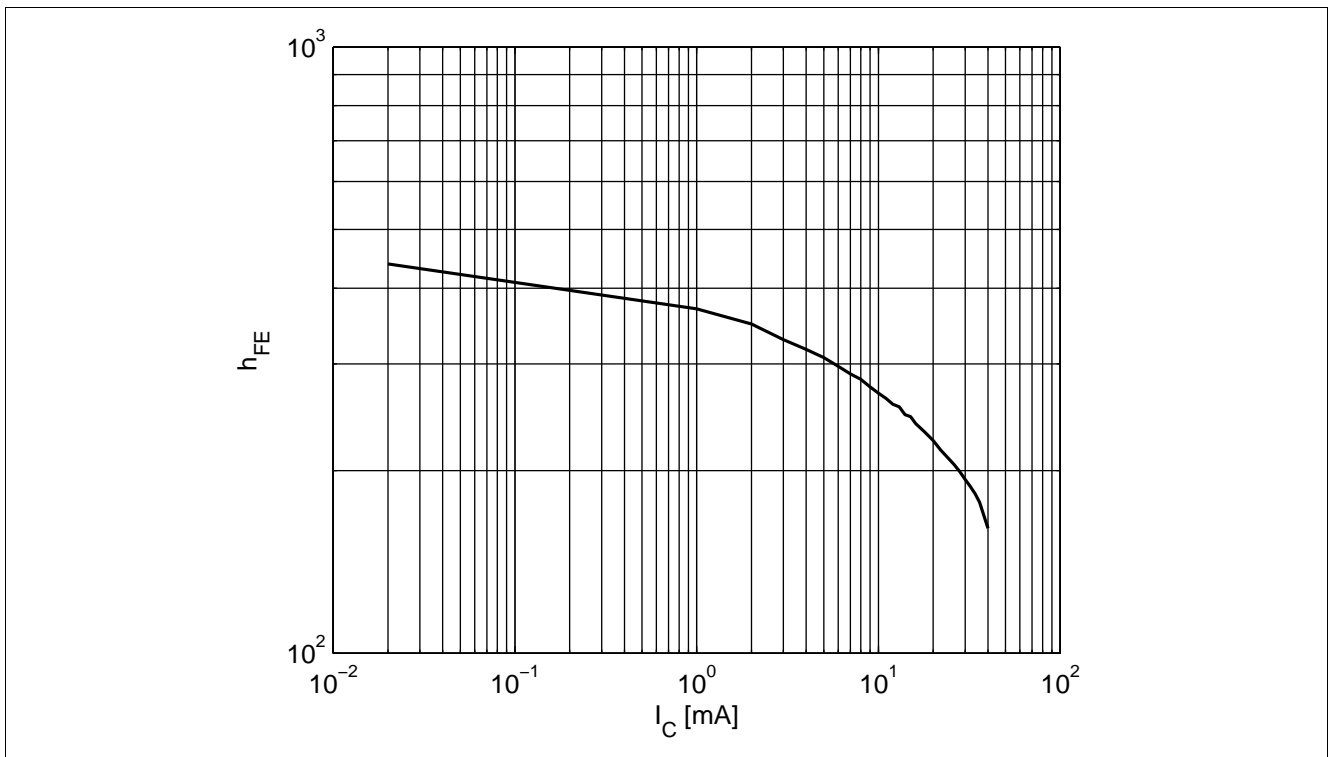


Figure 5-3 DC Current Gain $h_{FE} = f(I_C), V_{CE} = 1.8 \text{ V}$

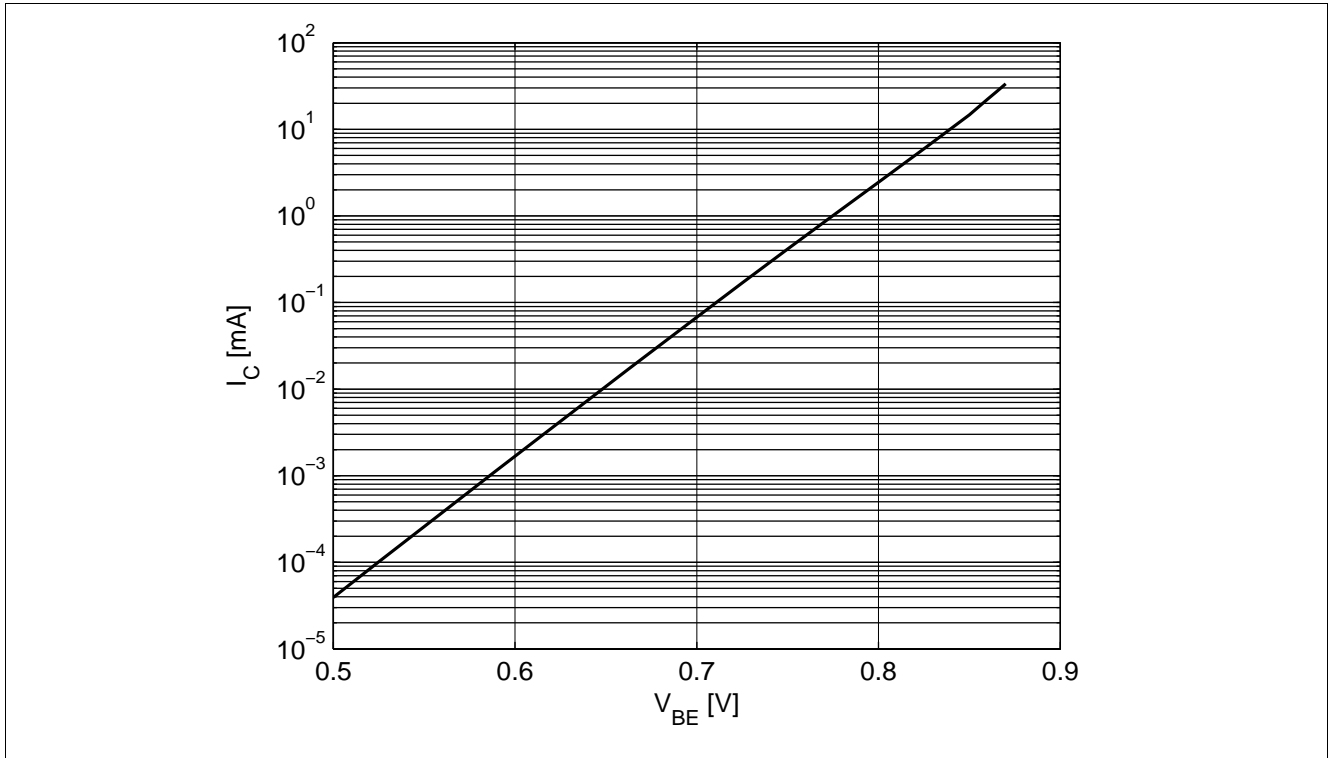


Figure 5-4 Collector Current vs. Base Emitter Forward Voltage $I_C = f(V_{BE})$, $V_{CE} = 1.8$ V

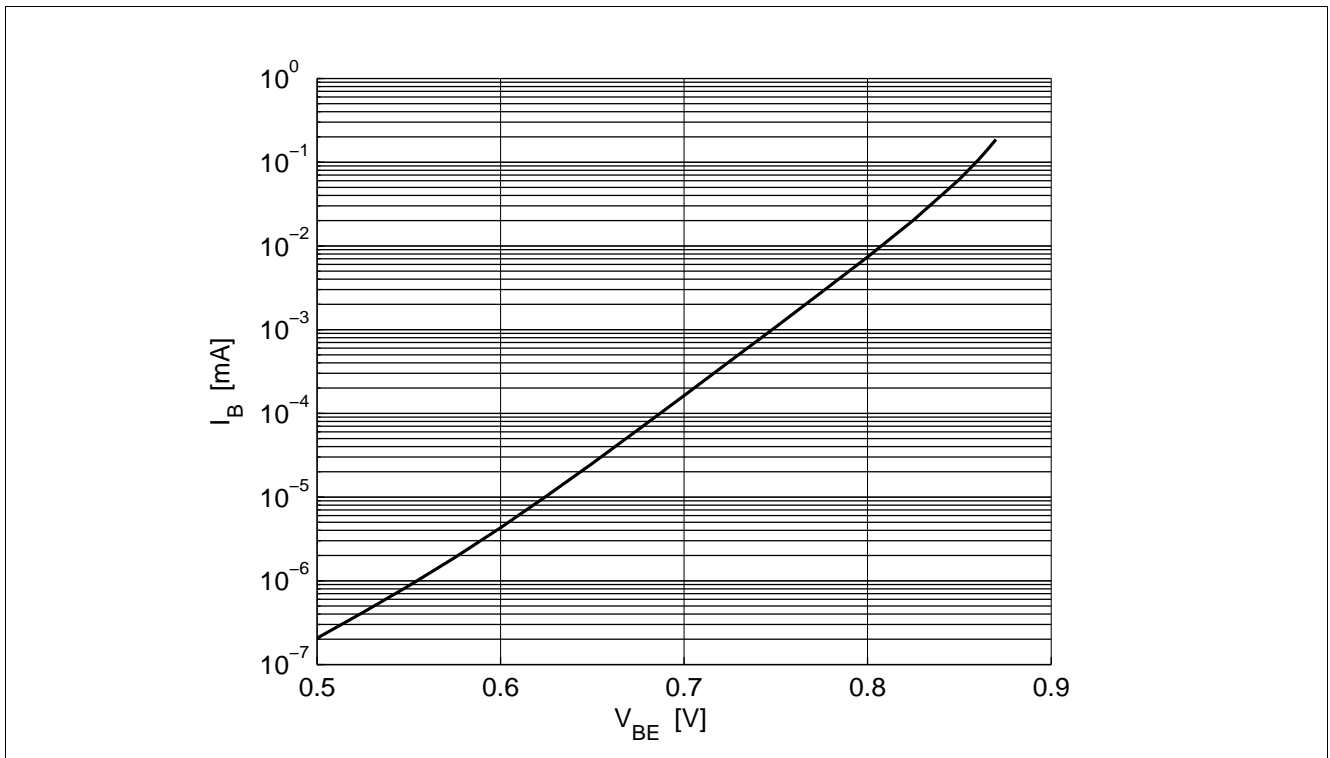


Figure 5-5 Base Current vs. Base Emitter Forward Voltage $I_B = f(V_{BE})$, $V_{CE} = 1.8$ V

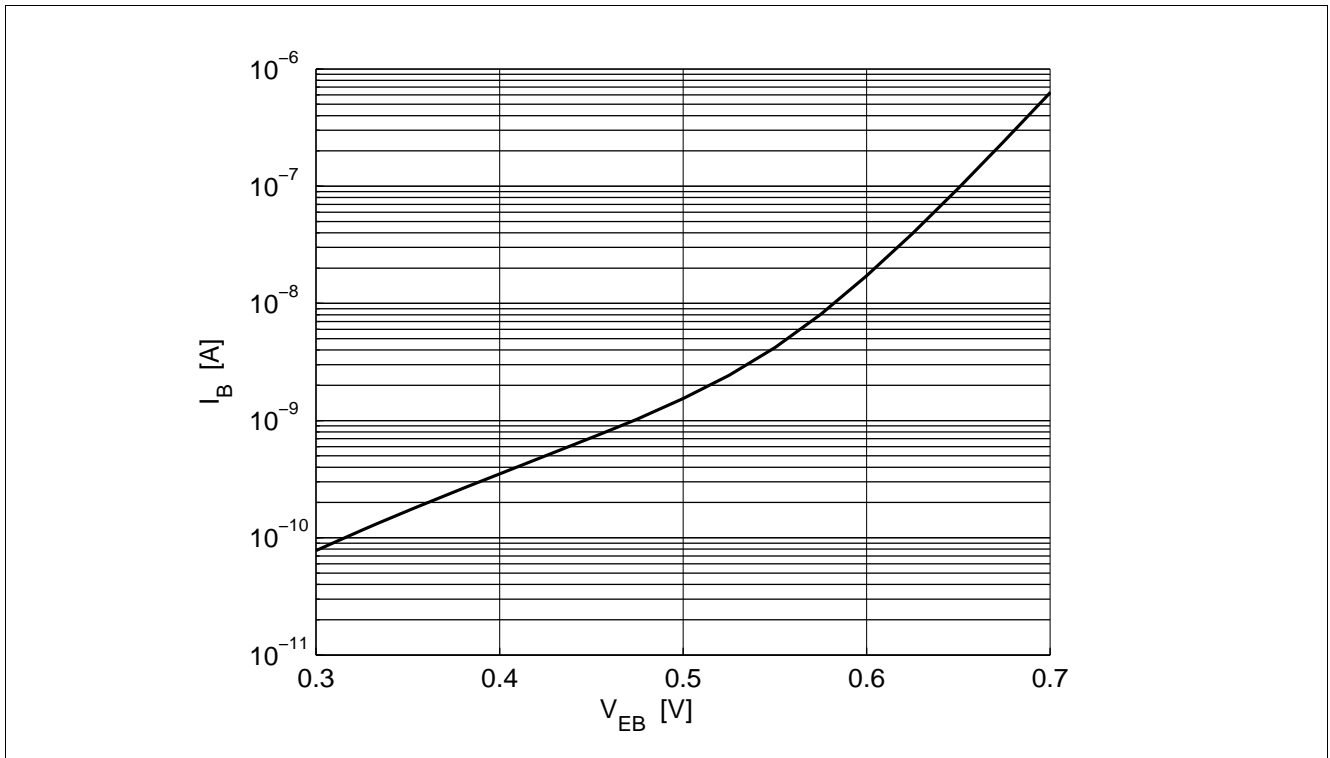


Figure 5-6 Base Current vs. Base Emitter Reverse Voltage $I_B = f(V_{EB})$, $V_{CE} = 1.8$ V

5.5 Characteristic AC Diagrams

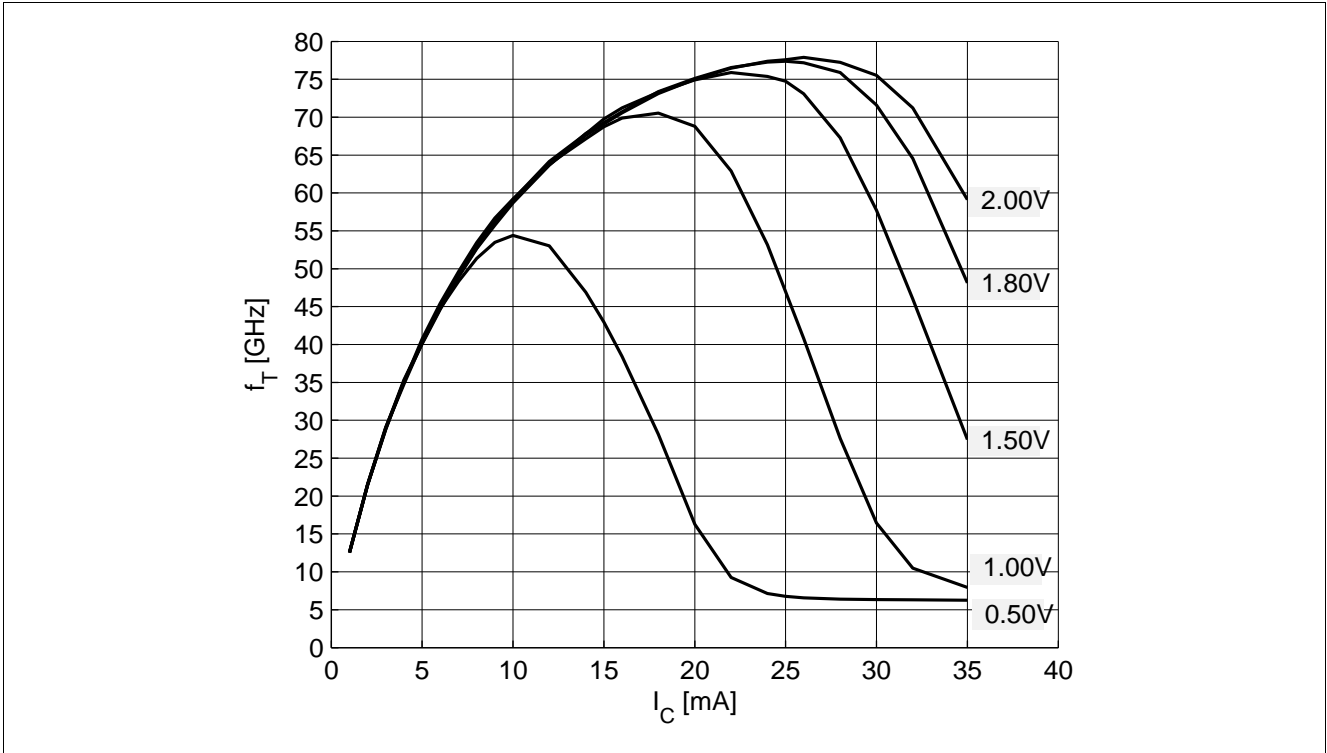


Figure 5-7 Transition Frequency $f_T = f(I_C)$, $f = 2 \text{ GHz}$, $V_{CE} = \text{Parameter}$

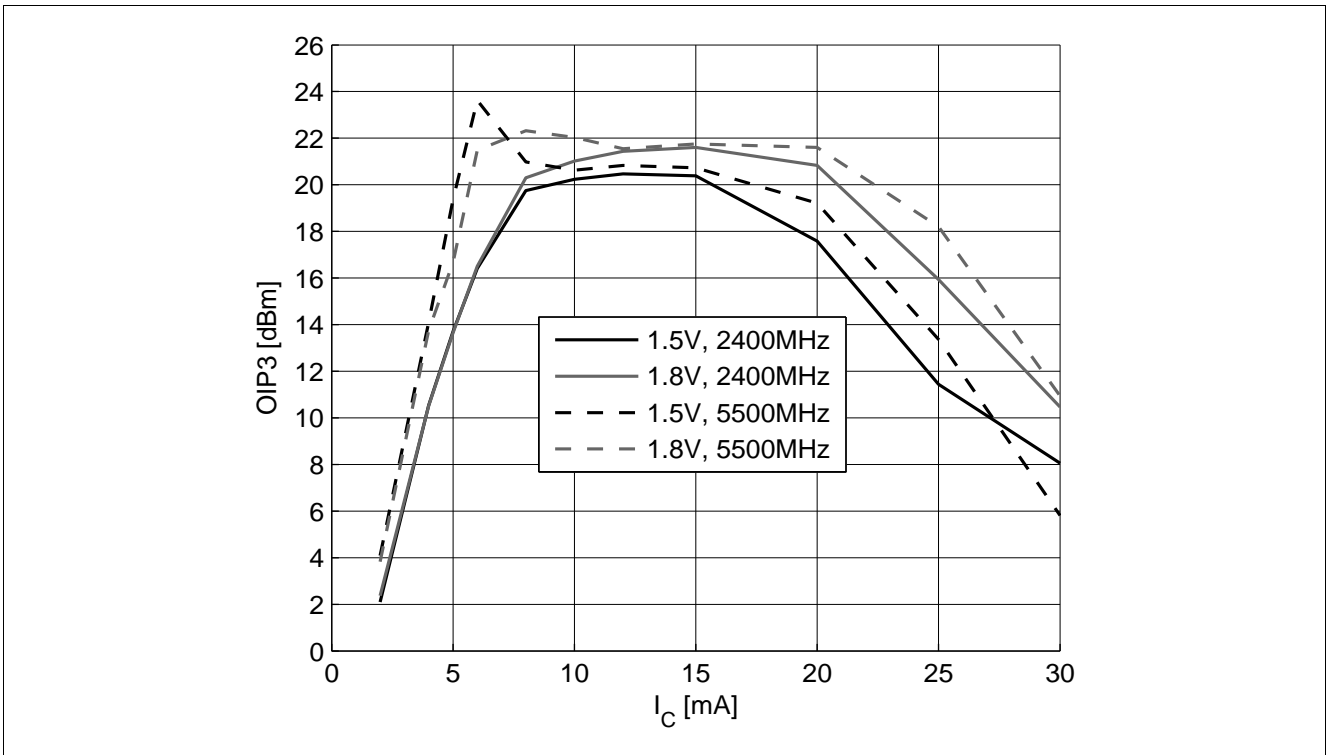


Figure 5-8 3rd Order Intercept Point at output $OIP3 = f(I_C)$, $Z_S = Z_L = 50 \Omega$, $V_{CE}, f = \text{Parameters}$

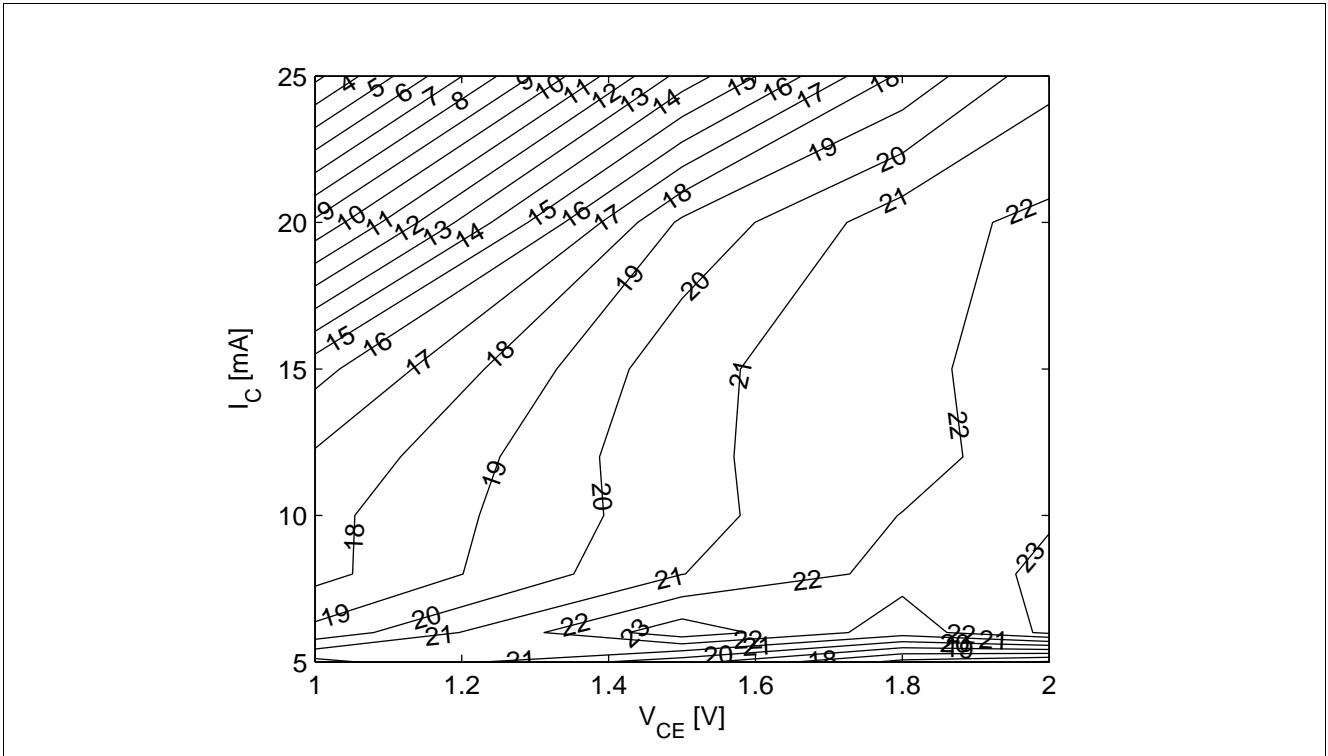


Figure 5-9 3rd Order Intercept Point at output $OIP3$ [dBm] = $f(I_C, V_{CE})$, $Z_S = Z_L = 50 \Omega$, $f = 5.5$ GHz

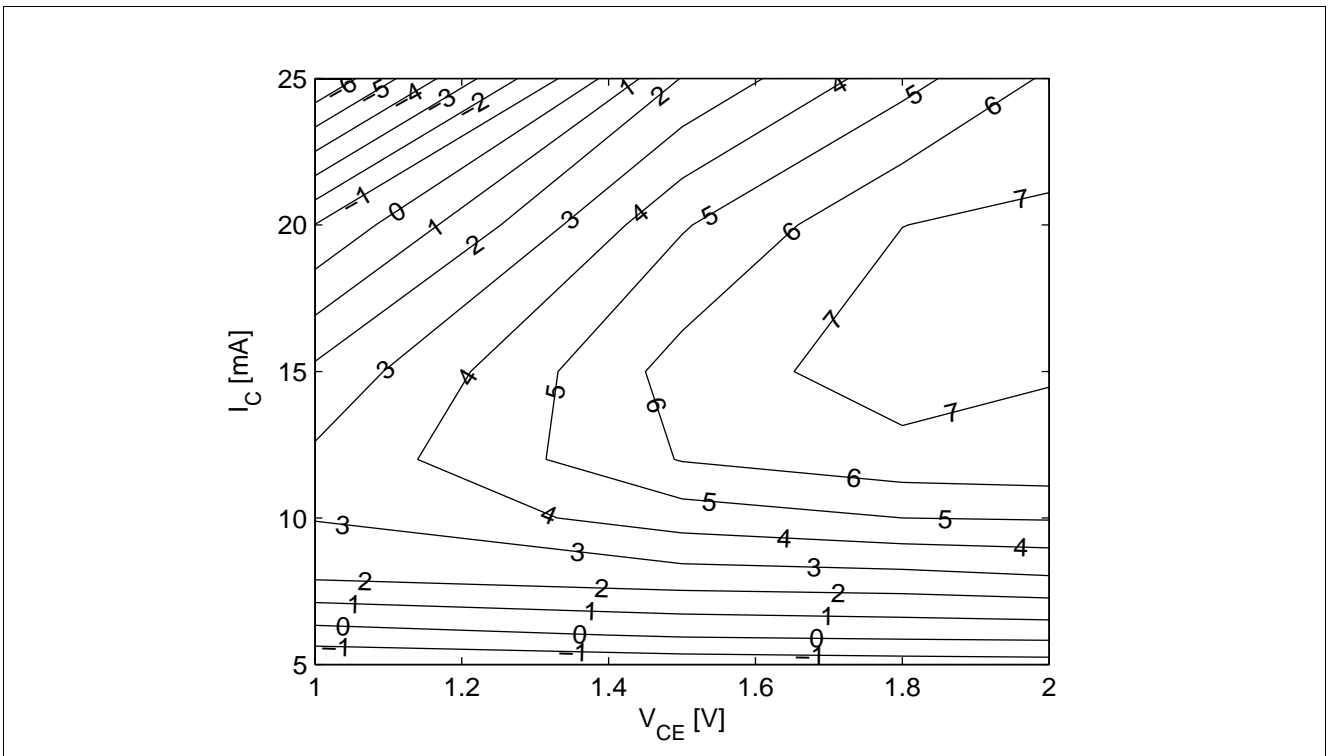


Figure 5-10 Compression Point at output OP_{1dB} [dBm] = $f(I_C, V_{CE})$, $Z_S = Z_L = 50 \Omega$, $f = 5.5$ GHz

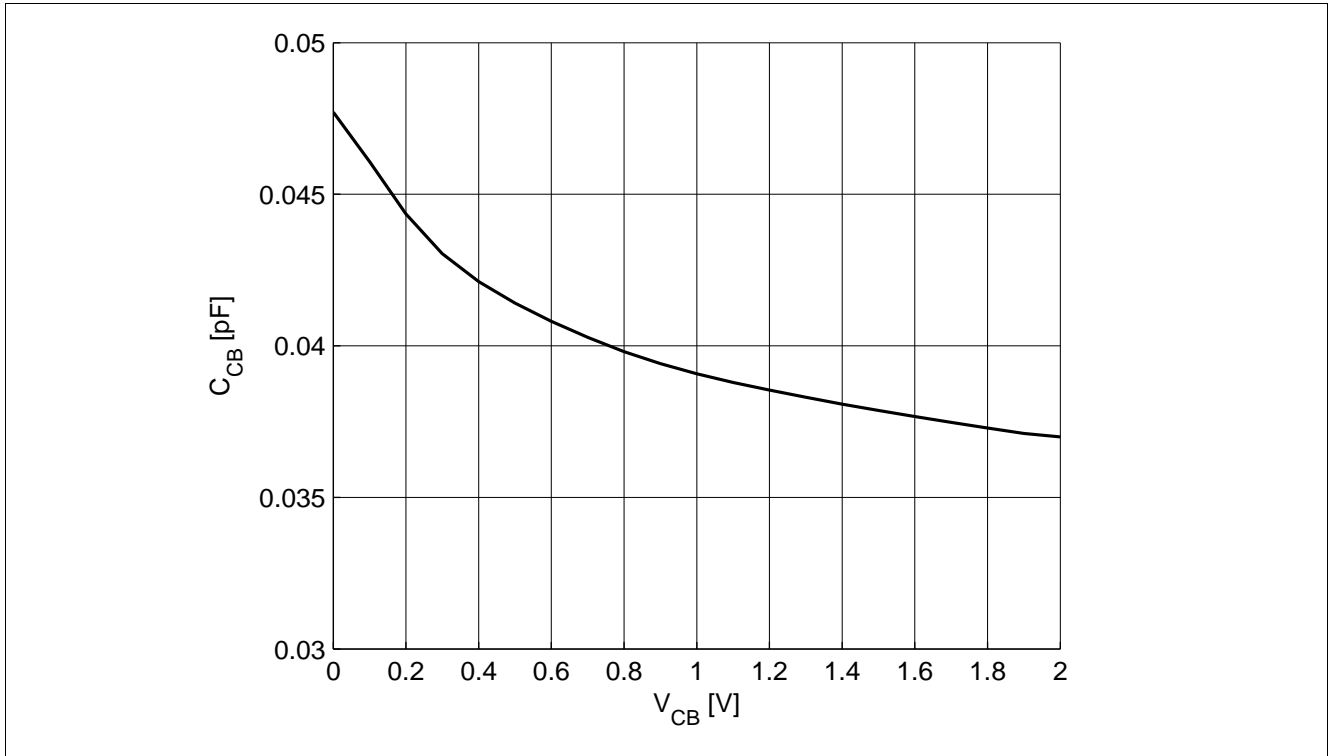


Figure 5-11 Collector Base Capacitance $C_{CB} = f(V_{CB}), f = 1$ MHz

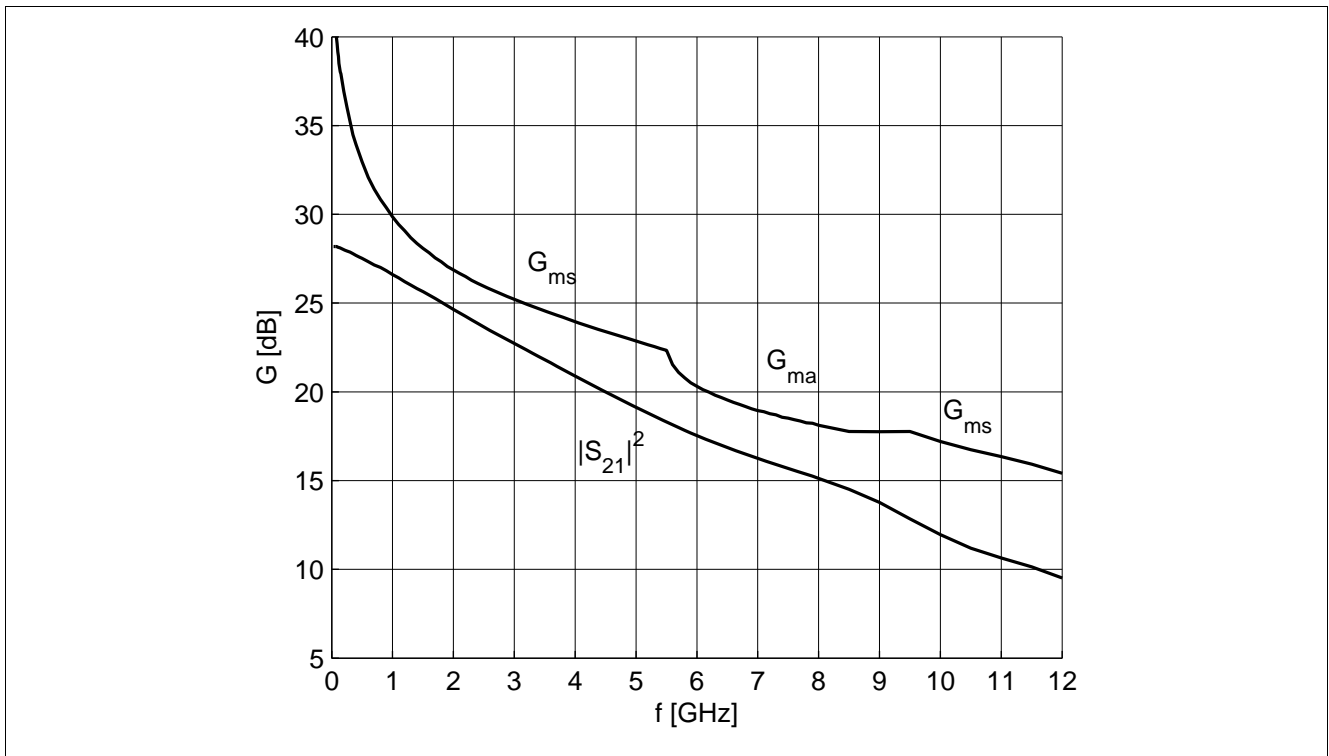


Figure 5-12 Gain $G_{ma}, G_{ms}, |S_{21}|^2 = f(f), V_{CE} = 1.8$ V, $I_C = 10$ mA

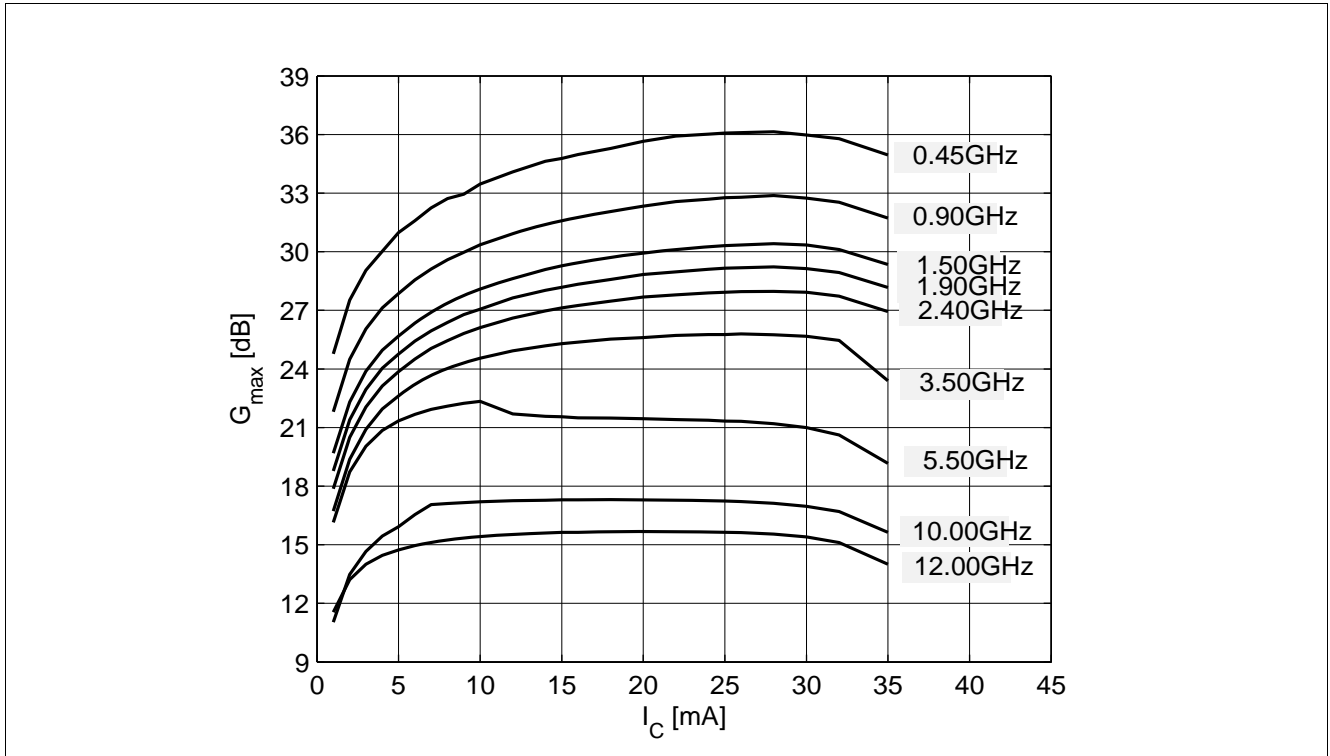


Figure 5-13 Maximum Power Gain $G_{max} = f(I_C)$, $V_{CE} = 1.8$ V, $f =$ Parameter in GHz

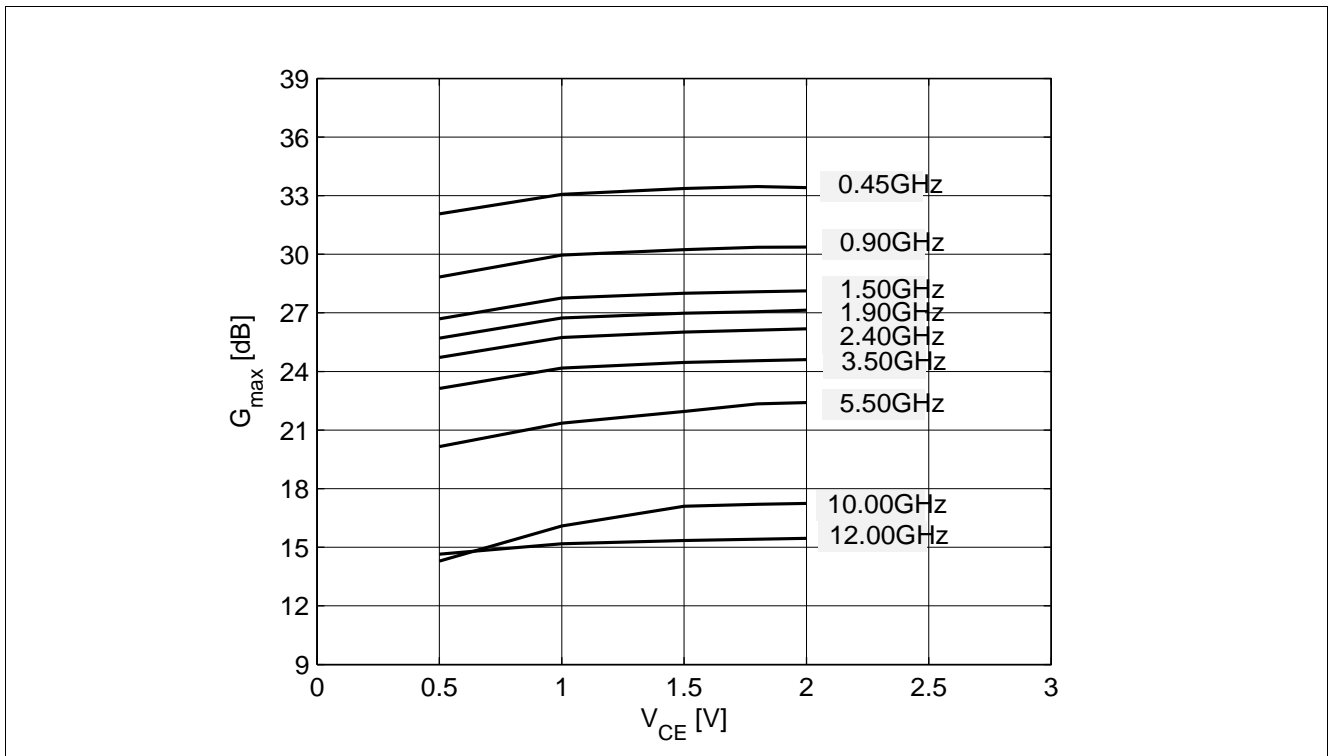


Figure 5-14 Maximum Power Gain $G_{max} = f(V_{CE})$, $I_C = 10$ mA, $f =$ Parameter in GHz

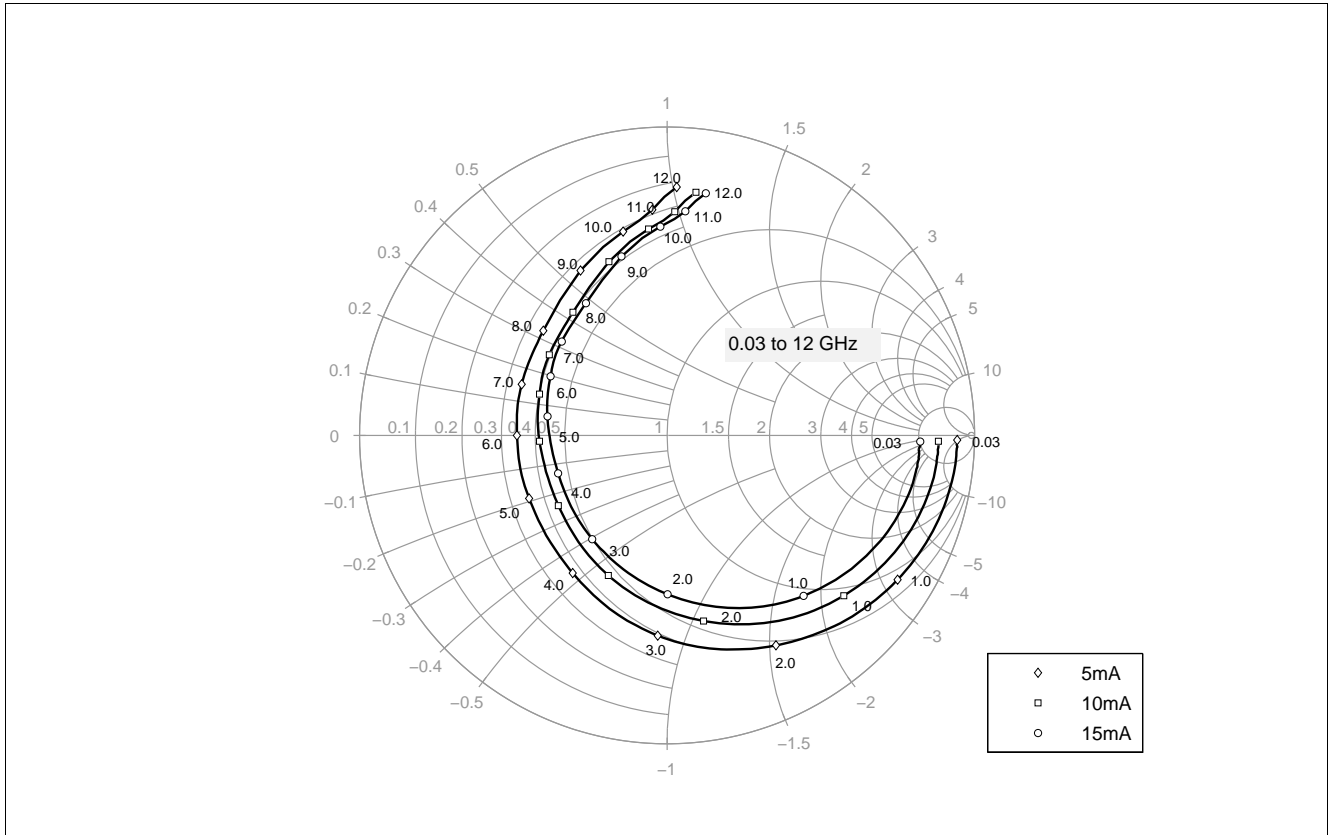


Figure 5-15 Input Reflection Coefficient $S_{11} = f(f)$, $V_{CE} = 1.8\text{ V}$, $I_C = 5 / 10 / 15\text{ mA}$

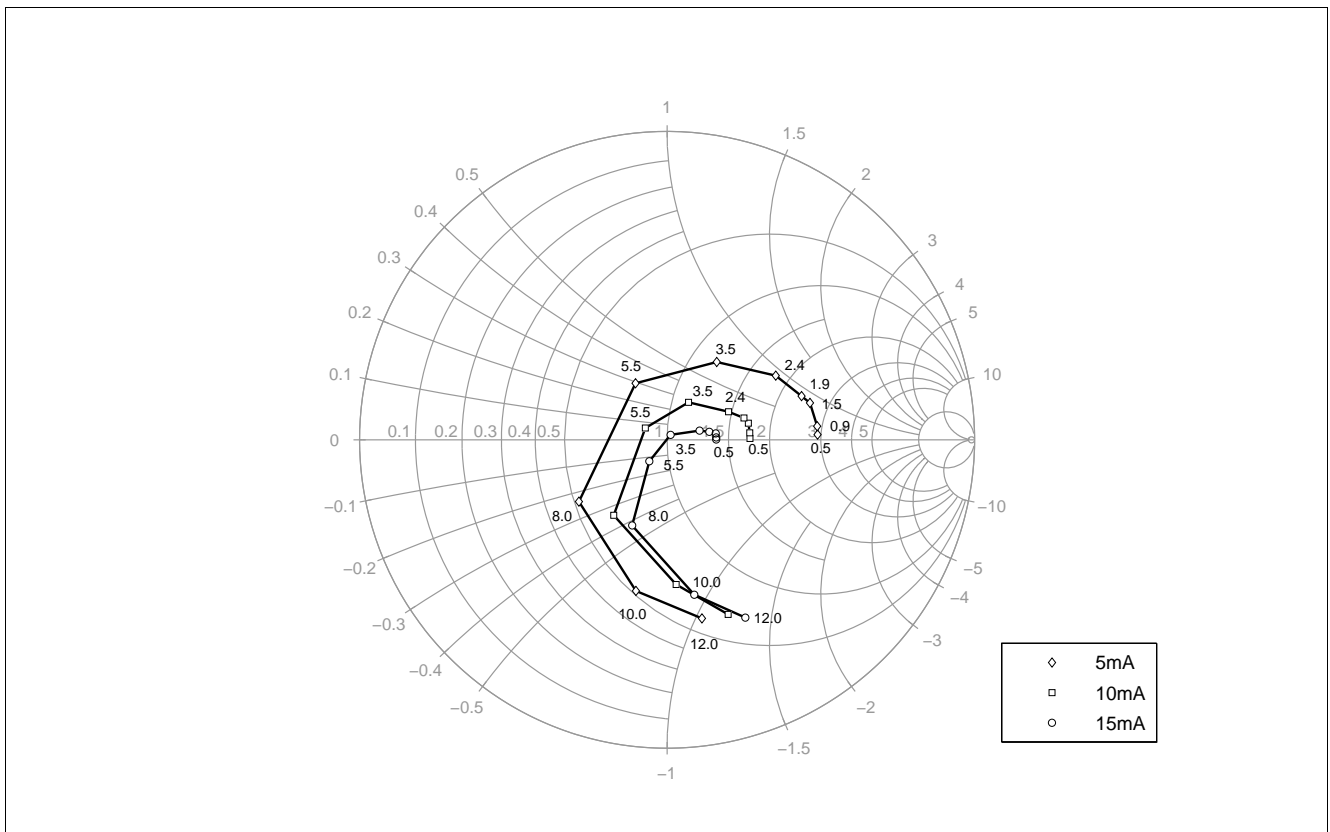


Figure 5-16 Source Impedance for Minimum Noise Figure $Z_{opt} = f(f)$, $V_{CE} = 1.8\text{ V}$, $I_C = 5 / 10 / 15\text{ mA}$

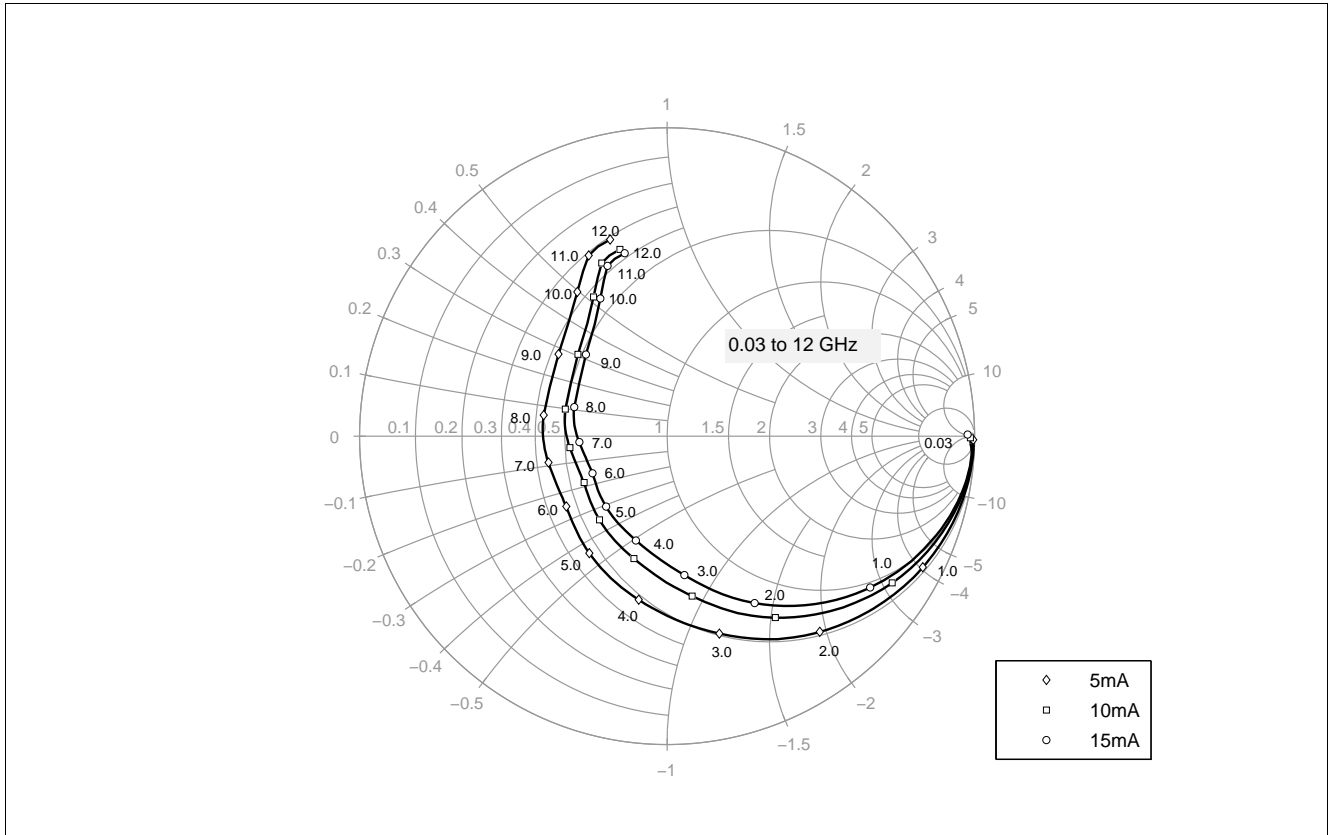


Figure 5-17 Output Reflection Coefficient $S_{22} = f(f)$, $V_{CE} = 1.8\text{ V}$, $I_C = 5 / 10 / 15\text{ mA}$

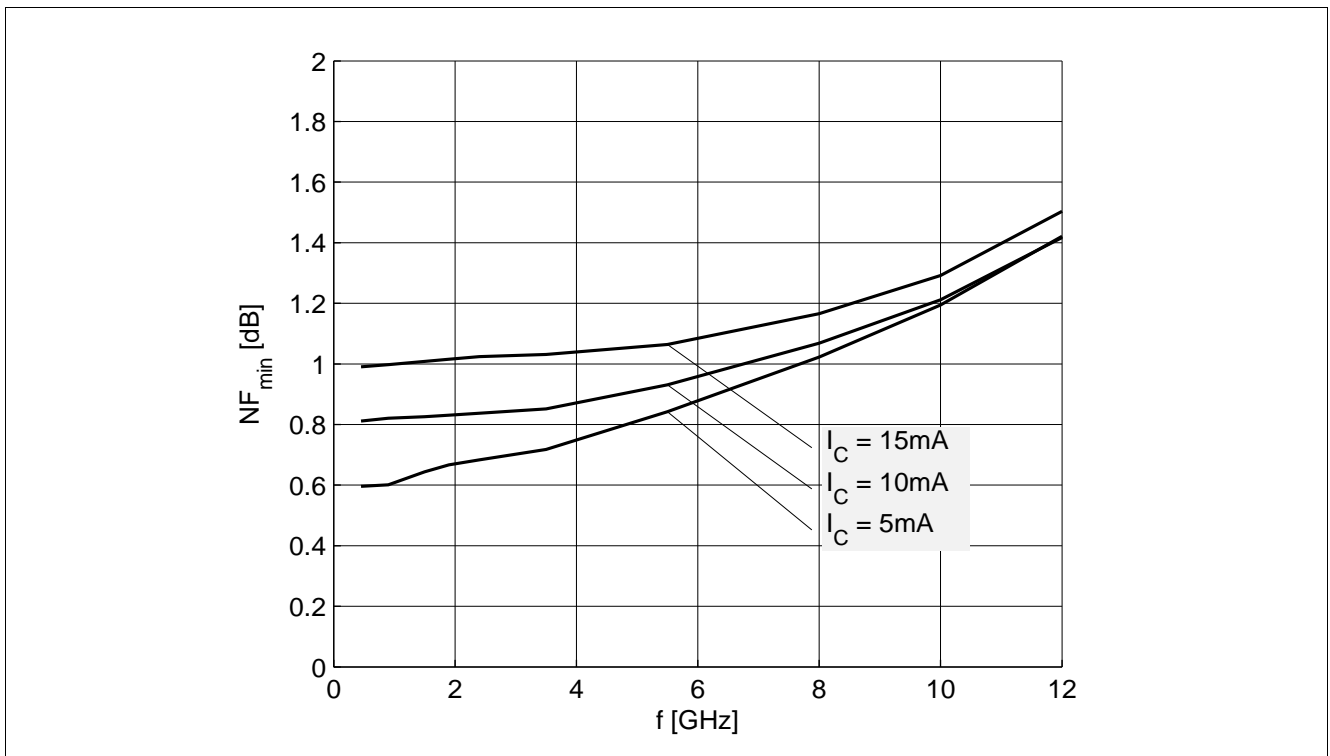


Figure 5-18 Noise Figure $NF_{\min} = f(f)$, $V_{CE} = 1.8\text{ V}$, $I_C = 5 / 10 / 15\text{ mA}$, $Z_S = Z_{\text{opt}}$

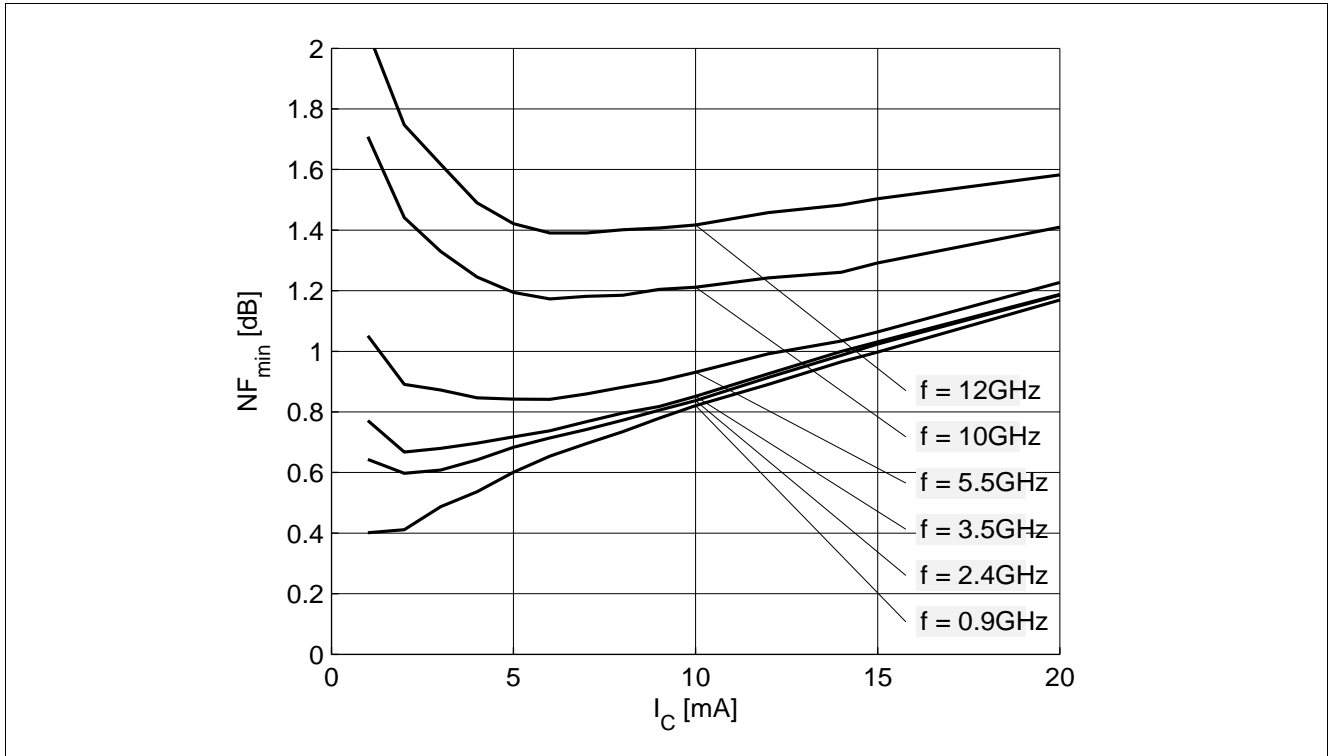


Figure 5-19 Noise Figure $NF_{min} = f(I_C)$, $V_{CE} = 1.8\text{ V}$, $Z_S = Z_{opt}$, $f = \text{Parameter in GHz}$

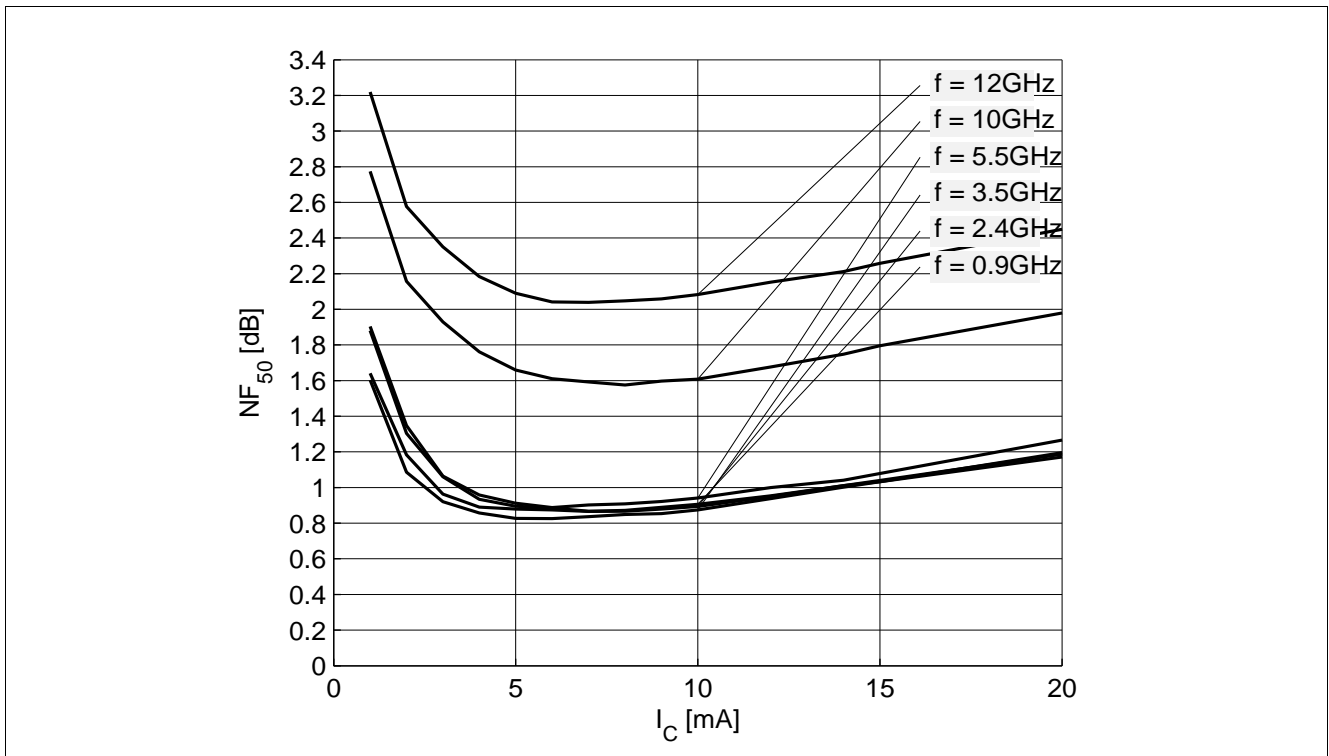


Figure 5-20 Noise Figure $NF_{50} = f(I_C)$, $V_{CE} = 1.8\text{ V}$, $Z_S = 50\ \Omega$, $f = \text{Parameter in GHz}$

Note: The curves shown in this chapter have been generated using typical devices but shall not be considered as a guarantee that all devices have identical characteristic curves. $T_A = 25\text{ }^\circ\text{C}$.

6 Simulation Data

For the SPICE Gummel Poon (GP) model as well as for the S-parameters (including noise parameters) please refer to our internet website. Please consult our website and download the latest versions before actually starting your design.

You find the BFP840ESD SPICE GP model in the internet in MWO- and ADS-format, which you can import into these circuit simulation tools very quickly and conveniently. The model already contains the package parasitics and is ready to use for DC and high frequency simulations. The terminals of the model circuit correspond to the pin configuration of the device.

The model parameters have been extracted and verified up to 12 GHz using typical devices. The BFP840ESD SPICE GP model reflects the typical DC- and RF-performance within the limitations which are given by the SPICE GP model itself. Besides the DC characteristics all S-parameters in magnitude and phase, as well as noise figure (including optimum source impedance, equivalent noise resistance and flicker noise) and intermodulation have been extracted.

7 Package Information SOT343

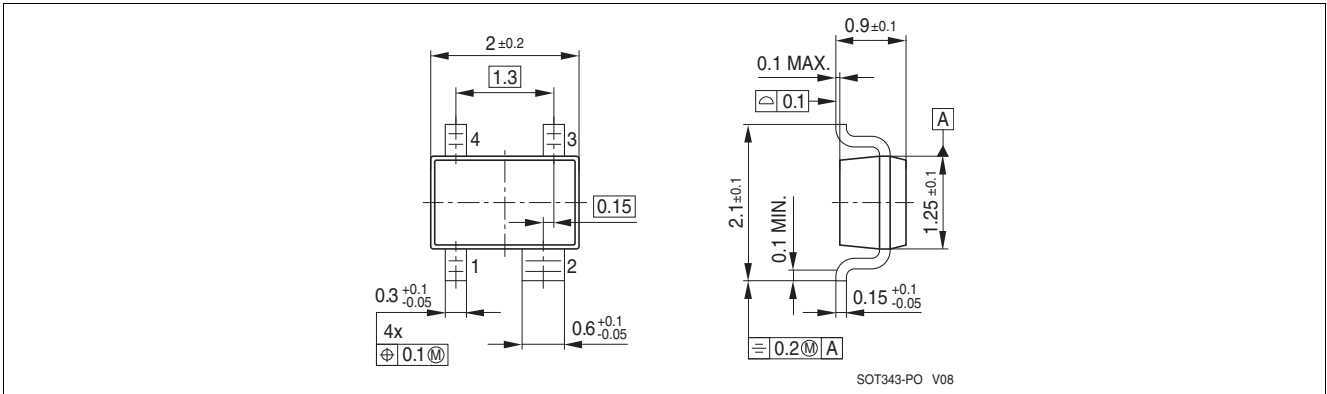


Figure 7-1 Package Outline

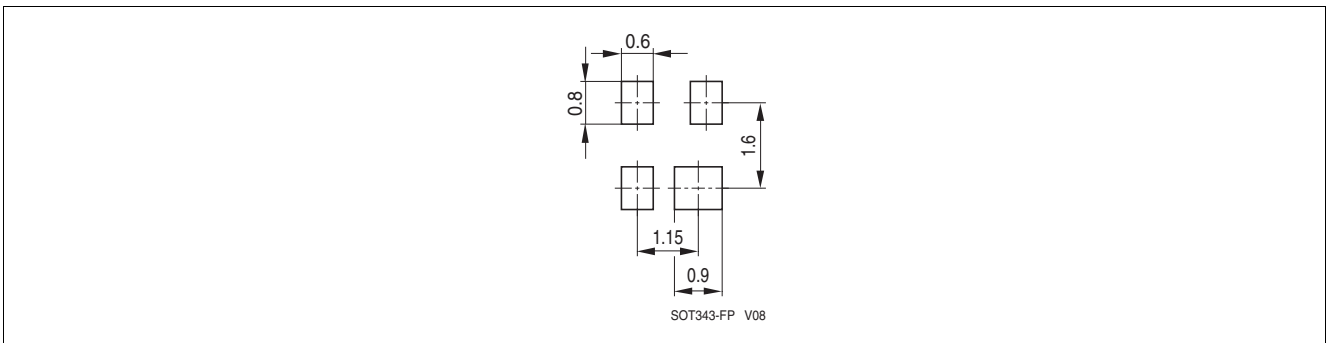


Figure 7-2 Package Footprint

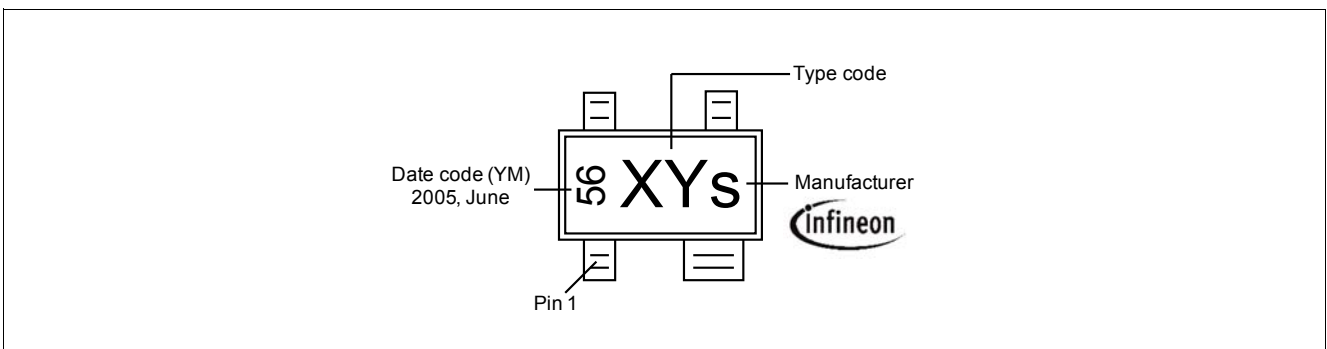


Figure 7-3 Marking Description (Marking BFP840ESD: T8s)

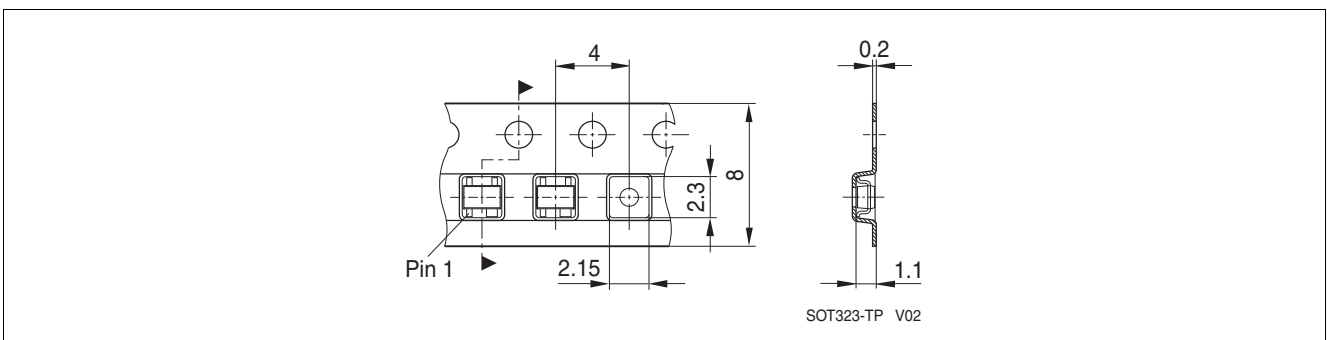


Figure 7-4 Tape Dimensions

www.infineon.com

Published by Infineon Technologies AG

Компания «Life Electronics» занимается поставками электронных компонентов импортного и отечественного производства от производителей и со складов крупных дистрибьюторов Европы, Америки и Азии.

С конца 2013 года компания активно расширяет линейку поставок компонентов по направлению коаксиальный кабель, кварцевые генераторы и конденсаторы (керамические, пленочные, электролитические), за счёт заключения дистрибьюторских договоров

Мы предлагаем:

- Конкурентоспособные цены и скидки постоянным клиентам.
- Специальные условия для постоянных клиентов.
- Подбор аналогов.
- Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.
- Приемлемые сроки поставки, возможна ускоренная поставка.
- Доставку товара в любую точку России и стран СНГ.
- Комплексную поставку.
- Работу по проектам и поставку образцов.
- Формирование склада под заказчика.
- Сертификаты соответствия на поставляемую продукцию (по желанию клиента).
- Тестирование поставляемой продукции.
- Поставку компонентов, требующих военную и космическую приемку.
- Входной контроль качества.
- Наличие сертификата ISO.

В составе нашей компании организован Конструкторский отдел, призванный помогать разработчикам, и инженерам.

Конструкторский отдел помогает осуществить:

- Регистрацию проекта у производителя компонентов.
- Техническую поддержку проекта.
- Защиту от снятия компонента с производства.
- Оценку стоимости проекта по компонентам.
- Изготовление тестовой платы монтаж и пусконаладочные работы.



Тел: +7 (812) 336 43 04 (многоканальный)

Email: org@lifeelectronics.ru